

Applicant(s)	Roohpar	INFORMATION DISCLOSURE STATEMENT FORM PTO-1449
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Examiner Name	Unknown	
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Title: SYNCHRONOUS FLASH MEMORY WITH ACCESSIBLE PAGE DURING WRITE		Sheet 1 Technology Center 2100

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Examiner Signature	<i>[Signature]</i>	Date Considered	9/30/03
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*Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.